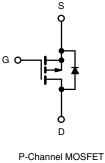


# P-Channel 100-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	<b>R<sub>DS(on)</sub> (</b> Ω <b>)</b>	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)		
- 100	0.200 at V <sub>GS</sub> = - 10 V	- 3.0	13.2 nC		
- 100	0.230 at V <sub>GS</sub> = - 6 V	- 2.4	13.2 110		





## FEATURES

- TrenchFET<sup>®</sup> Power MOSFET
- 100% R<sub>g</sub> and UIS Tested

#### **APPLICATIONS**

- Active Clamp in Intermediate DC/ DC Power Supplies
- H-Bridge High Side Switch for Lighting Application



Parameter		Symbol	Limit	Unit
Drain-Source Voltage		V <sub>DS</sub>	- 100	v
Gate-Source Voltage		V <sub>GS</sub>	± 20	V
	T <sub>C</sub> = 25 °C		- 3.0	
Continuous Drain Current (T 150 °C)	T <sub>C</sub> = 70 °C		-2.1	
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	- 2 <sup>a, b</sup>	
	T <sub>A</sub> = 70 °C		- 1.6 <sup>a, b</sup>	
Pulsed Drain Current		I <sub>DM</sub>	- 12	— A
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	1-	- 4.9	
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 2.5 <sup>a, b</sup>	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	- 15	
Single-Pulse Avalanche Energy	L = 0.1 mm	E <sub>AS</sub>	11.25	mJ
	T <sub>C</sub> = 25 °C		6.5	
Maximum Dower Dissinction	T <sub>C</sub> = 70 °C	P <sub>D</sub>	4.8	w
Maximum Power Dissipation	T <sub>A</sub> = 25 °C	ΓD	3.1 <sup>a, b</sup>	v
	T <sub>A</sub> = 70 °C	1	2 <sup>a, b</sup>	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 to 150	°C

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. t = 10 s.

THERMAL RESISTANCE RATINGS					
Parameter		Symbol	Typical	Maximum	Unit
Maximum Junction-to-Ambient <sup>a, b</sup>	t ≤ 10 s	R <sub>thJA</sub>	33	40	°C/W
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	17	21	0/11

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under steady state conditions is 80 °C/W.

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	L			<u> </u>		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 100			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 165		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$		-	- 6.6		mV/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 2		- 4	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA
Zara Cata Valtaga Drain Current		V <sub>DS</sub> = - 100 V, V <sub>GS</sub> = 0 V			- 1	μA
Zero Gate Voltage Drain Current	IDSS	$V_{DS}$ = - 100 V, $V_{GS}$ = 0 V, $T_{J}$ = 55 °C			- 10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge$ - 5 V, $V_{GS}$ = - 10 V	- 8			Α
		V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 3 A	0.200			<u> </u>
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 6 V, I <sub>D</sub> = - 2 A		0.230		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 15 V, I <sub>D</sub> = 3 A		12		S
Dynamic <sup>b</sup>				•		
Input Capacitance	C <sub>iss</sub>			819		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 35 V, V <sub>GS</sub> = 0 V, f = 1 MHz		51		pF
Reverse Transfer Capacitance	C <sub>rss</sub>		-	32		
	0	$V_{DS} = -50 \text{ V}, \text{ V}_{GS} = -10 \text{ V}, \text{ I}_{D} = -3 \text{ A}$		17.5	32	nC
Total Gate Charge	Q <sub>g</sub>			13.2	25	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ = - 50 V, $V_{GS}$ = - 6 V, $I_{D}$ = - 3 A		3.4		
Gate-Drain Charge	Q <sub>gd</sub>		-	6.4		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		6.1	9.2	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			10	20	
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 50 V, $R_L$ = 25 $\Omega$	-	55	95	
Turn-Off DelayTime	t <sub>d(off)</sub>	${ m I_D}\cong$ - 3 A, ${ m V_{GEN}}$ = - 6 V, ${ m R_g}$ = 1 $\Omega$	-	20	40	1
Fall Time	t <sub>f</sub>		-	15	30	
Turn-On Delay Time	t <sub>d(on)</sub>			11	18	ns
Rise Time	t <sub>r</sub>	$V_{DD}$ = - 50 V, $R_L$ = 25 $\Omega$	-	18	32	
Turn-Off DelayTime	t <sub>d(off)</sub>	$I_D \cong$ - 3 A, $V_{GEN}$ = - 10 V, $R_g$ = 1 $\Omega$	-	32	58	
Fall Time	t <sub>f</sub>		-	20	35	
Drain-Source Body Diode Characterist	ics		•	•	•	•
Continuous Source-Drain Diode Current	۱ <sub>S</sub>	T <sub>C</sub> = 25 °C			- 13	•
Pulse Diode Forward Current <sup>a</sup>	I <sub>SM</sub>				- 15	A
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 3 A		- 0.8	- 1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			65	90	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			180	270	nC
Reverse Recovery Fall Time	t <sub>a</sub>	$I_F = -3 \text{ A}, \text{ dl/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 ^\circ\text{C}$		45		
Reverse Recovery Rise Time	t <sub>b</sub>			20		ns

Notes:

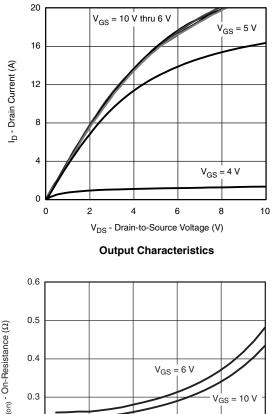
a. Pulse test; pulse width  $\leq$  300  $\mu s,$  duty cycle  $\leq$  2 %.

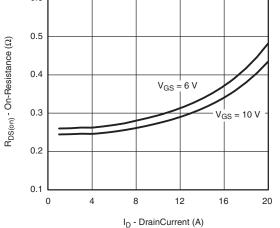
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

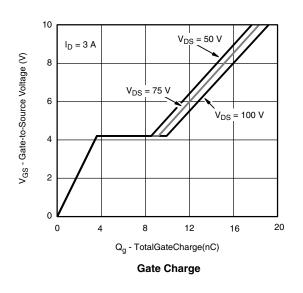
<u>VBsemi</u> Bsemi.com

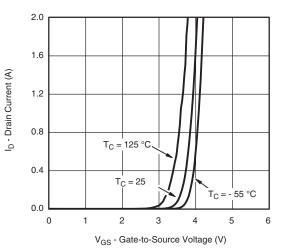




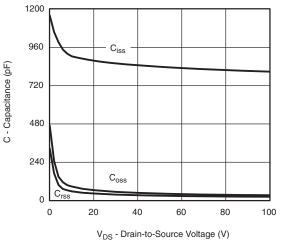


**On-Resistance vs. Drain Current and Gate Voltage** 

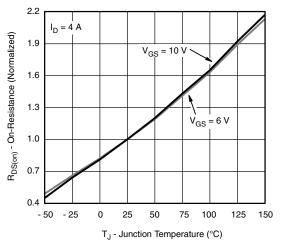




**Transfer Characteristics** 

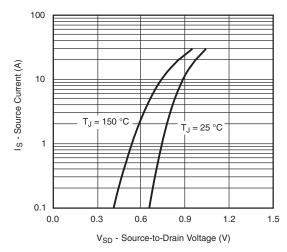


Capacitance

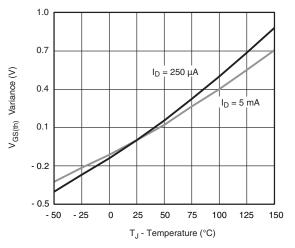


**On-Resistance vs. Junction Temperature** 

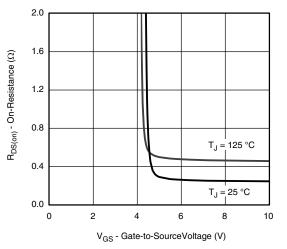




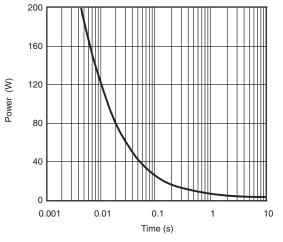
Source-Drain Diode Forward Voltage



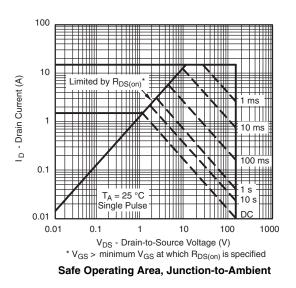
**Threshold Voltage** 



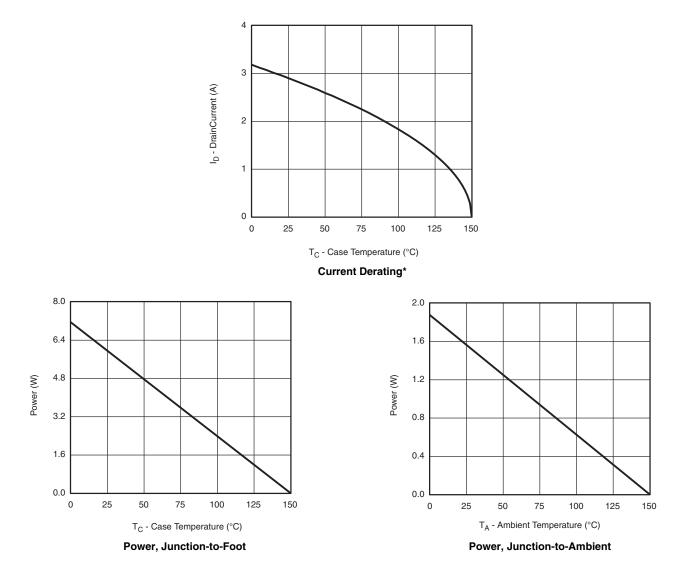
On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

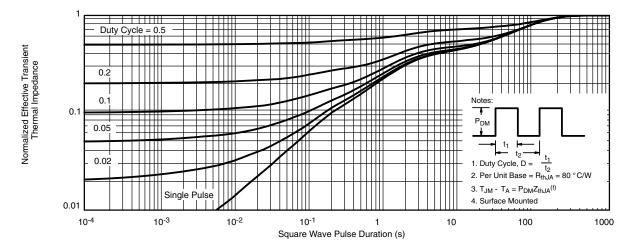




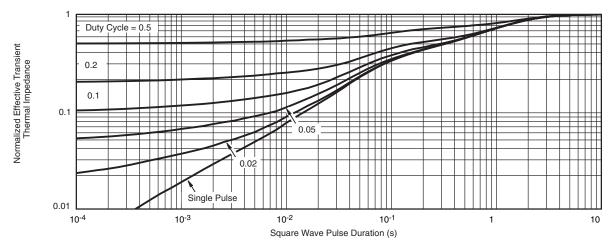


\* The power dissipation  $P_D$  is based on  $T_{J(max.)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





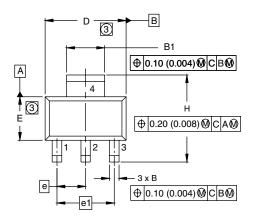
Normalized Thermal Transient Impedance, Junction-to-Ambient

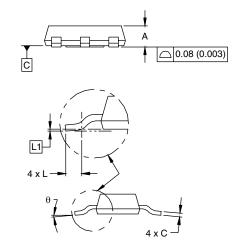


Normalized Thermal Transient Impedance, Junction-to-Foot



## SOT-223 (HIGH VOLTAGE)





DIM.	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
А	1.55	1.80	0.061	0.071	
В	0.65	0.85	0.026	0.033	
B1	2.95	3.15	0.116	0.124	
С	0.25	0.35	0.010	0.014	
D	6.30	6.70	0.248	0.264	
E	3.30	3.70	0.130	0.146	
е	2.30 BSC		0.0905 BSC		
e1	4.60 BSC		0.181 BSC		
Н	6.71	7.29	0.264	0.287	
L	0.91	-	0.036	-	
L1	0.061 BSC		0.0024 BSC		
θ	-	10'	-	10'	

#### Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimensions are shown in millimeters (inches).

3. Dimension do not include mold flash.

4. Outline conforms to JEDEC outline TO-261AA.



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